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Form PTO - 1449 (Modified)

TE HO 849	U.S. DEPARTMEN PATENT AND TR
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U.S. DEPARTMENT OF COMMERCE

PATENT AND TRADEMARK OFFICE

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APPLICANT Wise ot al.

FILING DATE 3/7/95

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N/74	AA	3	9	6	2	6	8	5	6/76	Belle-Isle	340	172.5	
)H	AB	4	1	4	9	2	4	2	4/79	Pirz	364	200	
DH.	AC	4	7	8	9	9	2	7	12/88	Hannah	364	200	
HC_	AD	4	8	2	3	2	0	1	4/18/89	Simon et al.	358	133	
MC	AE	4	8	6	6	6	3	7	9/12/89	Gonzalez-Lopez et al	364	518	(
#	AF	5	1	2	9	O.	5	9	7/7/92	Hannah	395	166.	(
74	AG	5	2	8	9	2	7	6	2/22/94	Siracusa et al.	348	467	
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HCUO	Al	5	3	0	1	2	4	2	4/5/94	Gonzales et al.	382	56	
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OTHER DOCUMENTS (Including Author, Title, Date**, Relevant Pages, Place of Publication***)

DN 74	AN	Chong, "A Data Flow Architecture For Digital Image Processing," Wescon Tech. Papers No. 4/6, 10/30/84, Anaheim, California, USA, pp. 1-10
DN2#	AO	Komori et al., "An Elastic Pipelline Mechanism By Self-Timed Circuits, IEEE Journal Of Solid-State Circuits, Vol. 23, No. 1, 2/88, New York, NY, USA, pp. 111-117
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APPLICANT ADRIAN P. WISE ET AL 05/776641

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DNDH	AA	3875391	04/01/75	SHAPIRO ET AL	235	156	11/02/73
744	A8	4225920	09/30/80	STOKES	364	200	09/11/78
74	AC	4228497	10/14/80	GUPTA ET AL	364	200	11/17/77
46	AD	4307447	12/22/81	PROVANZANO ET	364	200	06/19/79
<i>34</i> 7	AE	4467409	08/21/84	POTASH ET AL	364	200	08/05/80
HE	AF	4617657	10/14/86	ORYNAN ET AL	370	60	12/31/84
74	AG	4710866	12/01/87	ZOLNOWSKY ET AL	364	200	10/07/86
744	АН	4809159	02/28/89	SOWA	364	200	01/21/88
74	AI	4811214	03/07/89	NOSENCHUCK ET	364	200	11/14/86
46	AJ	4811413	03/07/89	KIMMEL	382	41	10/22/87
SH	AK	4841436	06/20/89	ASANO ET AL	364	200	05/30/86
JH	AL	4855947	08/08/89	ZAWSLOWSKI ET	364	200	05/27/87
24.	AM	4922418	05/01/90	DOLECEK	364	200	01/15/88
74	AN	4953082	08/28/90	NOMURA ET AL	364	200	02/15/89
7#	AO	4989138	01/29/91	RADOCHONSKI	364	200	05/14/90
7#	ΑР	5043880	08/27/91	YOSHIDA	364	200	01/23/89
744	AQ	5184347	02/02/93	Farwell et al.	370	94.1	07/09/91
7#	AR	5203003	04/13/93	DONNER	395	800	03/28/91
74	AS	5218436	06/08/93	SUGIYAMA ET AL	358	141	01/23/91
74	AT	5227863	07/13/93	Bilbrey et al.	348	578	08/07/90
46	AU	5297263	03/22/94	OHTSUKA ET AL	395	375	04/17/92
W 24	AV	5301344	04/05/94	KOLCHINSKY	395	800	01/29/91

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APPLICANT Wise et al. FILING DATE

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DNSH	AG	0	4	6	8	4	8	0	29.01.92	EP				

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DN24	Al	P. Yip, et al., "DIT and DIF Algorithm for Discrete Sine and Cosine Transforms" Proceedings of the International Symposium on Circuits and Systems, IEEE Press, New York, US, Vol. 2/3, 5 June 1985, Kyoto, JP, pages 941-944
DN 24	AJ	Hsieh S. Hou, "A Fast Recursive Algorithm for Computing the Discrete Cosine Transform," IEEE Transactions on Acoustics, Speech, and Signal Processing, Vol. 35, No. 10, October 1987, IEEE Press, New York, US, pages 1455-1461
previously cited	AK	Komori et al., "An Elastic Pipeline Mechanism By Self-Timed Circuits, IEEE Journal Of Solid State Circuits, Vol. 23, No. 1, 2/68, New York, NY, USA, pp. 111-117
DN 24	AL	A. Gupta et al., "A Fast Recursive Algorithm for the Discrete Sine Transform," IEEE Transactions on Acoustics, Speech, and Signal Processing, Vol. 38, No. 3, March 1990, IEEE Press, New York, US, pages 553-557
DN 24	AM	H.R. Wu, et al., "A Two Dimensional Fast Cosine Transform Algorithm Based on Hou's Approach," IEEE Transaction on Acoustics, Speech, and Signal Processing, Vol. 39, No. 2, February 1991, IEEE Press, New York, US, pages 544-546

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146	АР	4	2	1	5	3	6	9	7/29/80	lijima	358	146	12/15/78
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46	AR	4	3	3	4	2	4	6	6/8/82	Saran	358	261	5/16/80
7#	AS	4	4	3	3	3	0	8	2/21/84	Hirata	331	17	12/3/81
45	AT	4	4	3	7	0	7	2	3/13/84	Asami	331	1A	9/21/82
124	AU	4	4	9	5	6	2	9	1/22/85	Zasio et al.	377	70	1/25/83
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40	ВК	4	6	4	6	1	5	1	2/24/87	Welles II et al.	358	149	2/1/8	5
#	8L	4	6	7	9	1	6	3	7/7/87	Arnould et al.	364	725	3/8/8	5
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7#	BR	4	8	2	9	4	6	5	5/9/89	Knauer et al.	364	725	6/19/	36
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124	CE	4	9	0	3	0	1	8	2/20/90	Wiebach et al.	341	51	7/16/8	6
24	CF	4	9	1	2	6	6	8	3/27/90	Aubie et al.	364	725	6/5/87	
116	CG	4	9	2	2	3	4	1	5/1/90	Strobach	358	136	9/26/8	8 .
74	СН	4	9	2	4	2	9	8	5/8/90	Kitamura	358	12	9/15/8	8
14	CI	4	9	2	4	3	0	8	5/8/90	Feuchtwanger	358	133	3/7/89	
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34	CL	5	0	0	3	2	0	4.	3/26/91	Cushing et al.	307	465	12/19	189
146	СМ	5	0	2	7	2	1	2	6/25/91	Mariton et al.	358	183	12/6/8	19
344	CN	5	0	3	8	2	0	9	8/6/91	Hang	358	136	8/6/91	
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244	СР	5	0	5	7	7	9	3	10/15/91	Cowley et al.	331	1A	10/29	/90
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

APPLICANT Wise et al.

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1	<i>JH</i>	80	5	1	1	1	2	9	2	5/5/92	Kuriacose et al.	358	133	2/27/91
	24	DC	5	1	1	3	2	5	5	5/12/92	Nagata et al.	358	136	5/11/90
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	74	DG	5	1	2	6	8	4	2	6/30/92	Andrews et al.	358	133	12/26/90
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DN .	74	DI	5	1	3	0	5	6	8	7/14/92	Miller et al.	307	272.2	11/5/90
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10	140	OK	5	1	3	4	6	9	7	7/28/92	Scheffler	395	425	12/10/90
1:	HZ.	OL	5	1	3	5	3	7	1	8/4/92	Savatier et al.	358	133	3/15/90
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE

STATEMENT BY APPLICANT

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ATTY. DOCKET NO. PODD P941004(EP)USC1CIP

SERIAL NO.

APPLICANT Wise et al. 891276641

FILING DATE 03/07/95 GROUP 2317

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M124	DV	5	1	4	8	2	7	1	9/15/92	Kato et al.	358	133	4/17/91
7#	DW	5	1	4	8	5	2	4	9/15/92	Harlin et al.	395	166	11/29/88
74	οx	5	1	5	1	8	7	5	9/29/92	Sato	364	784	10/2/91
74	DY	5	1	5	9	4	4	9	10/27/92	Allmendinger	358	136	12/26/91
24	DZ	5	1	6	4	8	1	9	11/17/92	Music	358	13	4/3/91
<i>H</i>	EA	5	1	6	8	3	5	6	12/1/92	Acampora et al.	358	133	12/20/91
<i>H</i> C_	EB	5	1	6	8	3	7	5	12/1/92	Reisch et al.	358	432	9/18/91
714	EC	5	1	7	2	0	1	1	12/15/92	Leuthold et al.	307	272.2	6/30/89
74	ED	5	1	7	5	6	1	7	12/29/92	Wallace et al.	358	133	12/4/91
24	EE	5	1	7	9	3	7	2.	1/12/93	West et al.	340	799	3/28/91
74	EF	5	1	8	2	6	4	2	1/26/93	Gersdorff et al.	358	133	4/19/91
7#	EG	5	1	8	4	1	2	4	2/2/93	Molpus et al.	341	50	1/2/91
74	EH	5	1	8	5	8	1	9	2/9/93	Ng et al.	382	56	4/29/91
7#	EI	5	1	8	9	5	2	6	2/23/93	Şasson	358	432	9/21/90
DH	٤٦	5	1	9	1	5	4	8	3/2/93	Balkanski et al.	364	725	1/3/92
174	EK	5	1	9	3	0	0	2	3/9/93	Guichard et al.	358	133	3/25/91
W 74	EL	5	2	0	1	0	5	6	4/6/93	Daniel et al.	395	800	5/2/90

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34	ET	5	2	1	2	7	4	. 2	5/18/93	N	ormile et al.	382	56 .	5/24/	91
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24	EV	5	2	1	6	7	2	4	6/1/93	S	uzuki et al.	382	7	8/28/	92
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116	EZ	5	2	2	9	8	6	3	7/20/93	Ká	o et al.	358	426	12/24	1/90
24	FA	5	2	3	1	4	8	4	7/27/93	G	onzales et al.	358	133	11/8/	91
24	FB	5	2	3	1	4	8	6	7/27/93	A	campora et al.	358	133	7/27/	92
74	FC	5	2	3	3	4	2	0	8/3/93	Pi	ri et al.	358	149	4/10/	85
74	FD	5	2	3	3	6	9	0	8/3/93	SI	nerlock et al.	395	165	7/28/	89
344	FE	5	2	3	7	4	t	3	8/17/93	Isr	raelsen et al.	358	160	11/19	1/91
11	FF	5	2	4	1	2	2	2	8/31/93	Sr	nall et al.	307	449	12/20	1/91
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74	FR	5	2	5	3	0	7	8	10/12/93	Balkanski et al.	358	426	8/23/9	0	
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46	FX	5	2	6	0	7	8	2	11/9/93	Hui	358	133	8/31/9	12	
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24	G8	5	2	7	6	5	1	3	1/4/94	van der Wal et al.	358	136	6/10/9	92	
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	7#	GO	5	2	8	7	1	7	8	2/15/94	A	campora et al.	348	384	7/6/92
	74	GP	5	2	8	7	1.	9	3	2/15/94	Lit	า	358	261.1	6/14/91
_	74	GQ	5	2	8	7	4	2	0	2/15/94	Ва	mern	382	56	4/8/92
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	24	GV	5	2	9	8	8	9	6	3/29/94	Le	i et al.	341	51	3/15/93
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147H	нк	5	3	0	1	2	7	2	4/5/94	Atkins	395	165	11/25	5/92
HC	HL	5	3	0	3	3	4	2	4/12/94	Edge	395	164	12/22	2/92
146	нм	5	3	0	4	9	5	3	4/19/94	Heim et al.	331	1A	6/1/9	3
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Form PTO-1449 (Modified)

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY, DOCKET NO. 941004(EP)USC1X

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APPLICANT ADRIAN P. WISE ET AL 09/307239

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)

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HCM	AW	5309563	05/03/94	FARRAND ET AL	395	200	09/09/91
14	AX	5329313	07/12/94	KEITH	348	422	10/01/93
774	AY	5329619	07/12/94	PAGE ET AL	395	200	10/30/92
174	AZ	5333212	07/26/94	LIGTENBERG	382	56	11/17/92
74	8A	5333266	07/26/94	BOAZ ET AL	395	200	03/27/92
HC	88	5341371	08/23/94	SIMPSON	370	85.4	05/24/91
146	BC	5406279	04/11/95	ANDERSON ET AL	341	51	09/02/92
74	-BD	5414813	05/09/95	SHIOBARA	395	200	11/01/93
74	BE	5442790 -	08/15/95	NOSENCHUCK	395	700	03/09/94
7+	BF	5446866	08/29/95	DRAKO ET AL	395	500	01/30/92
H	BG	5450599	09/12/95	HORVATH ET AL	395	800	06/04/92
174	вн	5452006	09/19/95	AULD	348	390	10/25/93
146	81	5461679	10/24/95	NORMILE ET AL	395	650	05/14/93
7#	81	5481689	01/02/96	STAMM ET AL	395	412	08/13/93
7#	8K	5487064	01/23/96	GALAND ET AL	370	60	05/31/94
74	BL	5490247	02/06/96	TUNG ET AL	395	162	11/24/93
_ 14	вм	5497498	03/05/96	TÄYLOR	395	800	09/28/93
74	BN	5504869	04/02/96	UCHIDA:	395	375	07/15/94
744	во	5535290	07/09/96	Allen	382	250	09/11/95
11.14	ВР	5566089	10/15/96	HOOGENBOOM	364	514A	10/26/94
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- - -	15H	P01	ELLIOTT J A ET AL: "REAL-TIME SIMULAȚION OF VIDEOPHONE IMAGE CODING ALGORITHMS ON RECONFIGURABLE MULTICOMPUTERS," IEEE PROCEEDINGS E. COMPUTERS & DIGITAL TECHNIQUES, VOL. 139, NO. 3 PART E., 05/01/92, PP 269-279, XP0000306411.
	74	P02	HONG, YANG-CHANG: T.H. PAYNE. A HYBRID APPROACH FOR EFFICIENT DATAFLOW COMPUTING, COMPUTERS AND COMMUNICATIONS, 1990 INT'L PHOENIX CONFERENCE. IEEE PUBLICATIONS, MAY 1990 PP 170-178.
	74	P03	KAORU, UCHIDA ET AL: "A PIPELINED DATAFLOW PROCESSOR ARCHITECTURE BASED ON A VARIABLE LENGTH TOKEN CONCEPT," ARCHITECTURE, UNIVERSITY PARK, AUG. 15 · 19, 1988, VOL. 1, 15 AUGUST 1988, BRIGGS F A, PP 209-216, XP000079309.
	146	P04	KOPET, TOM: "PROGRAMMABLE ARCHITECTURES FOR REAL-TIME VIDEO COMPRESSION," 4TH INTERNATIONAL CONFERENCE ON SIGNAL PROCESSING APPLICATIONS & TECHNOLOGY, VOL. 2, 09/28/93 - 10/01/93. SANTA CLARA, CALIFORNIA, USA, PP 1031-1038.
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EXAMINER

DATE CONSIDERED

6/6/97

EXAMINER: Initial citation considered. Drawline through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.